Power MOSFET 30 V, 34 A, Single N-Channel, µ8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Power Load Switch
- Notebook Battery Management
- Motor Control

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Paran	neter		Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage	Gate-to-Source Voltage				V
Continuous Drain		$T_A = 25^{\circ}C$	I _D	11.2	А
Current R _{0JA} (Note 1)		$T_A = 85^{\circ}C$		8.0	
Power Dissipation $R_{\theta JA}$ (Note 1)		$T_A = 25^{\circ}C$	P _D	2.16	W
Continuous Drain		T _A = 25°C	Ι _D	15.7	А
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		$T_A = 85^{\circ}C$		11.3	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	T _A = 25°C	P _D	4.30	W
Continuous Drain	State	T _A = 25°C	I _D	7.1	А
Current $R_{\theta JA}$ (Note 2)		T _A = 85°C		5.1	
Power Dissipation $R_{\theta JA}$ (Note 2)		$T_A = 25^{\circ}C$	PD	0.89	W
Continuous Drain		$T_{\rm C} = 25^{\circ}{\rm C}$	I _D	34	А
Current $R_{\theta JC}$ (Note 1)		$T_C = 85^{\circ}C$		24.4	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	PD	20	W
Pulsed Drain Current	T _A = 25°	C, t _p = 10 μs	I _{DM}	102	А
Operating Junction and S	T _J , T _{stg}	–55 to +150	°C		
Source Current (Body Die	۱ _S	20	А		
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-So ($T_J = 25^{\circ}C$, $V_{DD} = 50$ V, V I _L = 23 A _{pk} , L = 0.1 mH, F	E _{AS}	26.5	mJ		
Lead Temperature for So (1/8" from case for 10 s)	ΤL	260	°C		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability. 1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

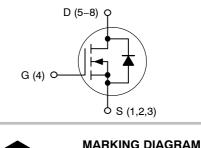


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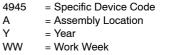
V _{(BR)DSS} R _{DS(on)} MAX		I _D MAX
30 V	9.0 m Ω @ 10 V	34 A
	13 m Ω @ 4.5 V	54 7

N-Channel MOSFET





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sd	4945	DD
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= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS4945NTAG	WDFN8 (Pb-Free)	1500/Tape & Reel
NTTFS4945NTWG	WDFN8 (Pb-Free)	5000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{\theta JC}$	6.3	°C/W
Junction-to-Ambient - Steady State (Note 3)	$R_{\theta JA}$	57.8	
Junction-to-Ambient – Steady State (Note 4)	$R_{\theta JA}$	141.2	
Junction-to-Ambient – (t \leq 10 s) (Note 3)	R_{\thetaJA}	29.1	

3. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size (40 mm², 1 oz. Cu).

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condit	ion	Min	Тур	Max	Unit
OFF CHARACTERISTICS							•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D = 2$	250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				15		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 24 V$	$T_J = 125^{\circ}C$			10	1
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} =$	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	250 μΑ	1.2	1.7	2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}		I _D = 20 A		6.4	9.0	mΩ
	V _{GS} = 10 V	I _D = 10 A		6.4		1	
			I _D = 20 A		9.5	13	
		V _{GS} = 4.5 V	I _D = 10 A		9.3		
Forward Transconductance	g fs	V _{DS} = 1.5 V, I _D	= 15 A		28.5		S

CHARGES AND CAPACITANCES

Input Capacitance	C _{iss}			1194		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz, V _{DS} = 15 V		470		
Reverse Transfer Capacitance	C _{rss}	1		11		
Total Gate Charge	Q _{G(TOT)}			7.7		nC
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = 4.5 V, V_{DS} = 15 V, I_{D} = 20 A		2.1		
Gate-to-Source Charge	Q _{GS}			4.0		
Gate-to-Drain Charge	Q _{GD}	1		1.1		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 15 V, I_{D} = 20 A		17.3		nC
SWITCHING CHARACTERISTICS (Note 6)						

$\begin{tabular}{|c|c|c|c|c|c|c|} \hline Turn-On \ Delay \ Time & t_{d(on)} & \\ \hline Rise \ Time & t_r & \\ \hline Turn-Off \ Delay \ Time & t_{d(off)} & \\ \hline Fall \ Time & t_f & \\ \hline \end{tabular}$

5. Pulse Test: pulse width = 300 $\mu s,$ duty cycle \leq 2%.

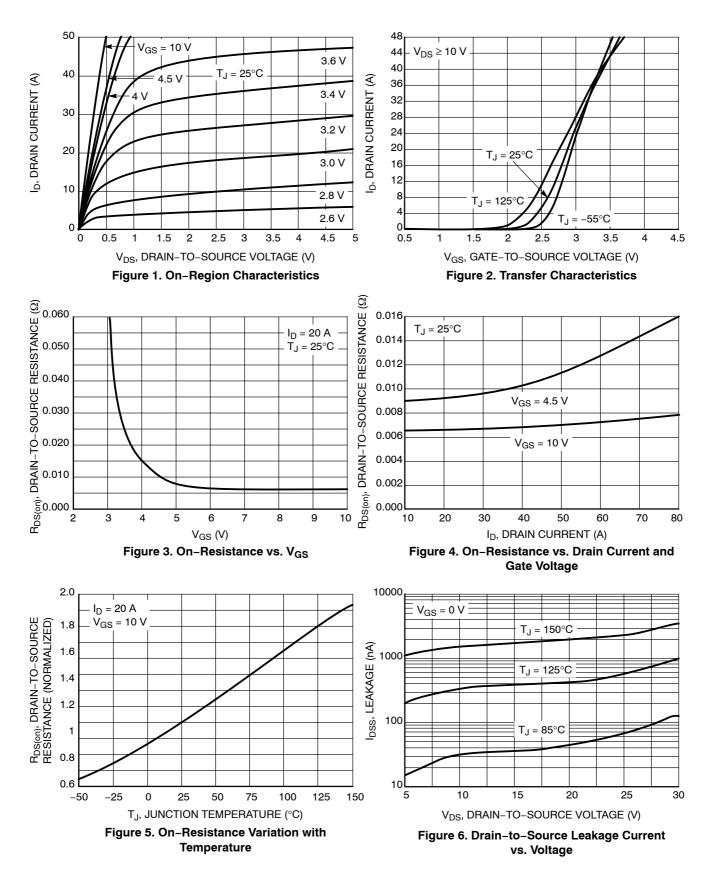
6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

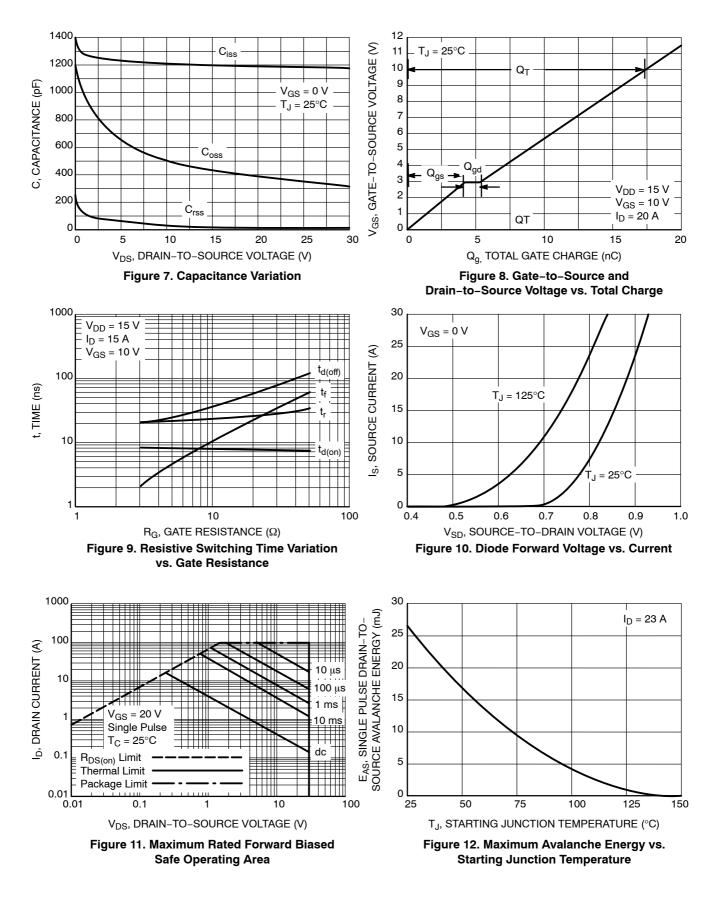
Parameter	Symbol	Test Conditi	on	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS	S (Note 6)						
Turn-On Delay Time	t _{d(on)}				7.0		ns
Rise Time	tr	V _{GS} = 10 V, V _{DS} =	= 15 V,		19		
Turn-Off Delay Time	t _{d(off)}	$I_{\rm D} = 15 \rm A, R_{\rm G} =$	3.0 Ω [´]		20		
Fall Time	t _f		ſ		2.0		
DRAIN-SOURCE DIODE CHARA	CTERISTICS				•	-	-
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.81	1.0	V
		$I_{\rm S} = 20 {\rm A}$	T _J = 125°C		0.73		
Reverse Recovery Time	t _{RR}				28.5		ns
Charge Time	t _a	$V_{GS} = 0 V_{t} d_{1S}/d_{t} =$	100 A/μs,		15.2		
Discharge Time	t _b	$V_{GS} = 0 V, d_{IS}/d_t = I_S = 20 A$			13.3		
Reverse Recovery Charge	Q _{RR}		ſ		17.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S	T _A = 25°C			0.38		nH
Drain Inductance	L _D				0.054		
Gate Inductance	L _G				1.3		
Gate Resistance	R _G				1.1	2.0	Ω

 $\begin{array}{ll} \text{5. Pulse Test: pulse width = 300 } \mu\text{s, duty cycle } \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

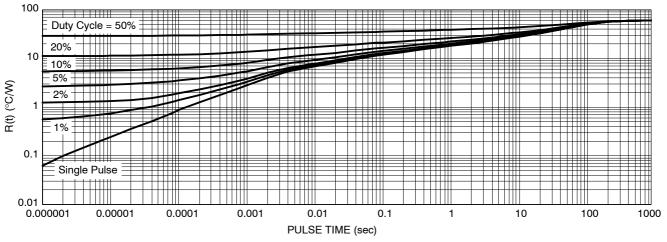
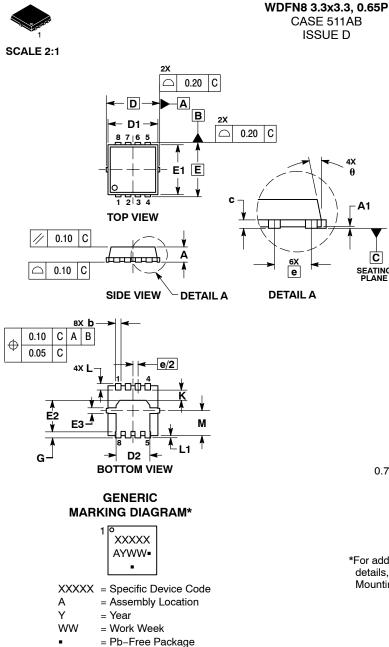


Figure 13. Thermal Response

DUSEU

DATE 23 APR 2012



*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

NOTES:

A1

C

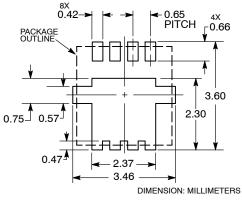
SEATING PLANE

LES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 1. 2.

- 3.

	MI	LLIMETE	RS		INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	3.30 BSC			0	.130 BSC)	
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E		3.30 BSC		0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	(0.026 BS0	2	
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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